

# GalnP/Silicon dual junction solar cell with 29.8 % certified record efficiency

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## From Silicon Heterojunction Solar Cells towards Silicon Based Tandem Cells

**Silicon based PV devices roadmap**

- IBC: 23 - 25 %
- IBC - HETEROJUNCTION: Record 25.6 %
- HETEROJUNCTION: Record 25.1 %
- CZ PERC: 20 - 21 %
- mc: 19 - 20 %
- Theoretical limit c-Si single cell: 29.4 %

### TANDEM SOLAR CELLS:

- Combination of high band-gap (1.5 -1.8 eV) top cell with low band-gap (0.8 -1.2 eV) bottom cell.
- Short-wavelength photons converted in top cell, reducing thermalization losses, yielding additional voltage. Long-wavelength photons non-absorbed below the bandgap of top cell, absorbed in bottom cell.
- Top cell materials investigated by PV community for combination with Silicon bottom cell: **PEROVSKITE materials** and **III-V semiconductor materials**

### SILICON HETEROJUNCTION SOLAR CELLS:

Competitive high-performance technology, ideally suited for tandem integration

- Simple processing sequence
- High conversion efficiency (22.8 % on CSEM platform on 156 x 156mm<sup>2</sup> full wafer n-Cz cell, measured w. GridTouch)
- Compatible with thin wafers (100 μm) without performance loss
- Key advantages in the field for low LCOE: low temperature coefficient (-0.2 to -0.25 %/°C), bifacial.

*Maximum theoretical efficiency for tandem cells, taken from: I. Almansouri et al., IEEE JPV Vol.5, 2015*

R&D silicon heterojunction platform set up in CSEM

SHJ CELL	VOC mV	FF %	JSC mA/cm <sup>2</sup>	EFF %
Full 6" PS n-type Cz 160 μm	736	79.8	38.8	22.8

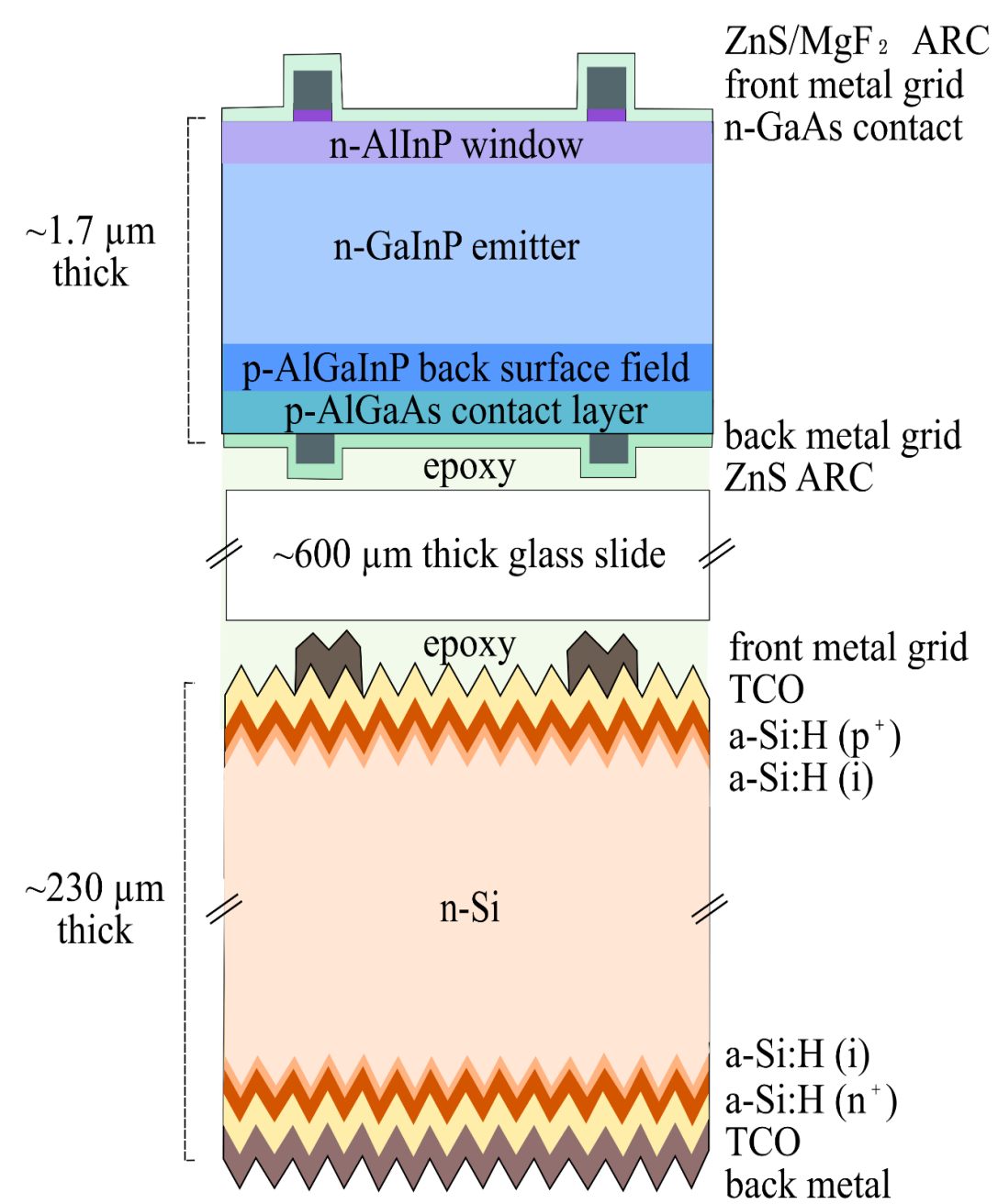
*Measured with GridTouch®*

## GalnP/Silicon Heterojunction TANDEM CELL

### Experimental Details:

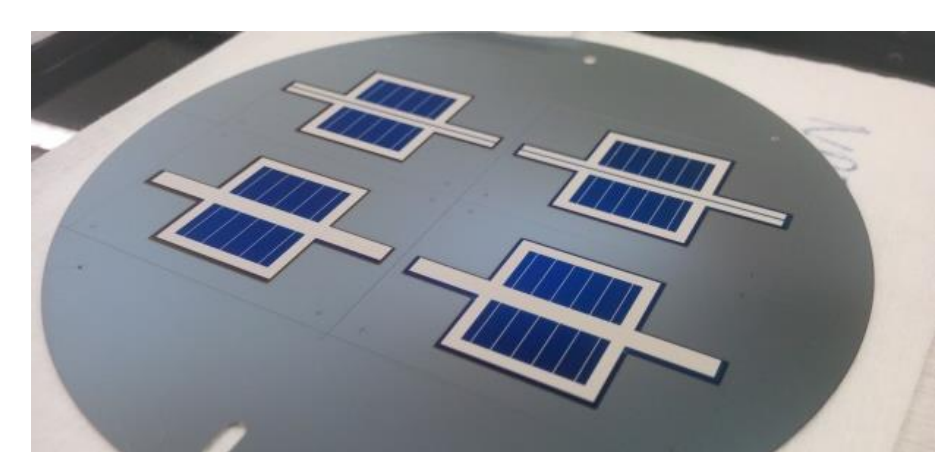
#### NREL GalnP top cell:

1.7 μm thick rear-heterojunction GalnP with active area of ~ 1 cm<sup>2</sup> grown by MOVPE on a GaAs substrate. Gold back contact grid electroplated and ZnS ARC layer evaporated on the cell backside. Sample glued to a glass slide, and GaAs growth substrate removed. Front gold contacts electroplated, n-GaAs contact layer etched in the regions without front metal, and ZnS/MgF<sub>2</sub> dual-layer anti-reflection coating evaporated.



#### CSEM Silicon Heterojunction bottom cell:

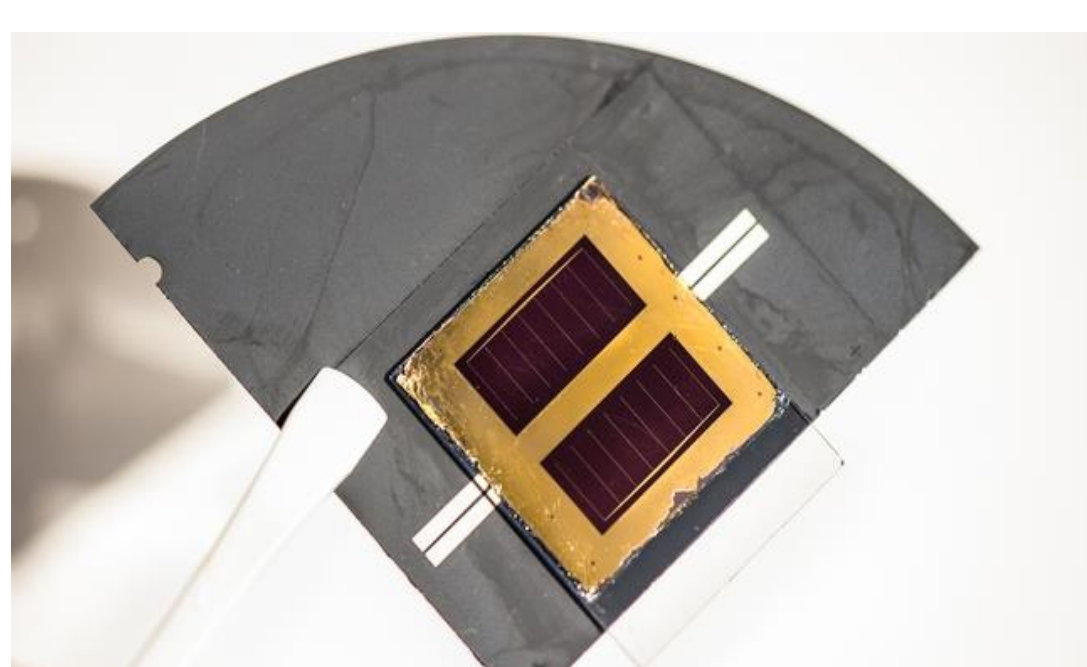
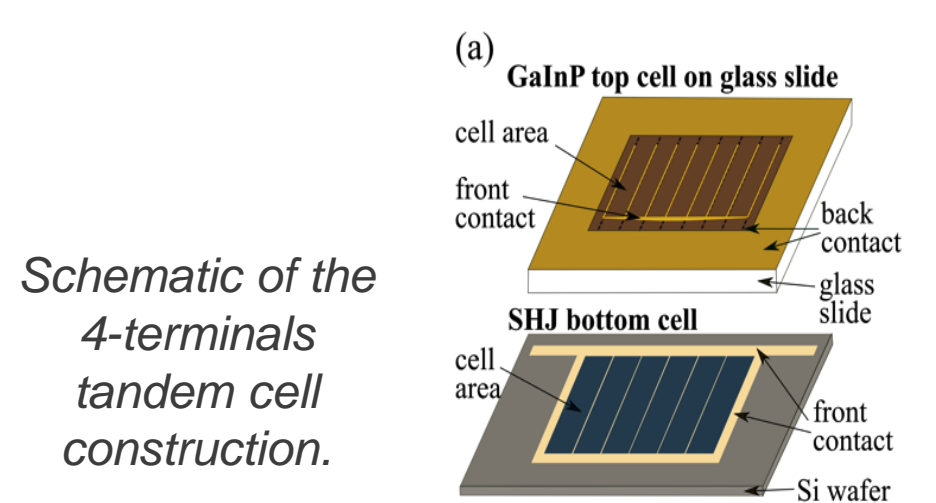
a-Si:H deposited on 230 μm thick n-Fz wafer: intrinsic/n-type doped on the rear, intrinsic/p-type doped on the front, TCO layers on both sides, rear Ag sputtering, front printed metallization grid. Special TCO patterning and metallization grid designed for enabling efficient coupling to the GalnP top cell area and glass substrate dimension.



> 1 cm<sup>2</sup> CSEM Silicon heterojunction solar cells patterned for integration with NREL GalnP top cells.

#### GalnP/SHJ tandem:

GalnP/Si tandem devices formed by stacking the glass slide with the top cell glued to it onto the bottom cell using a transparent adhesive. Alignment of the two subcells verified using infrared reflection before curing the adhesive.

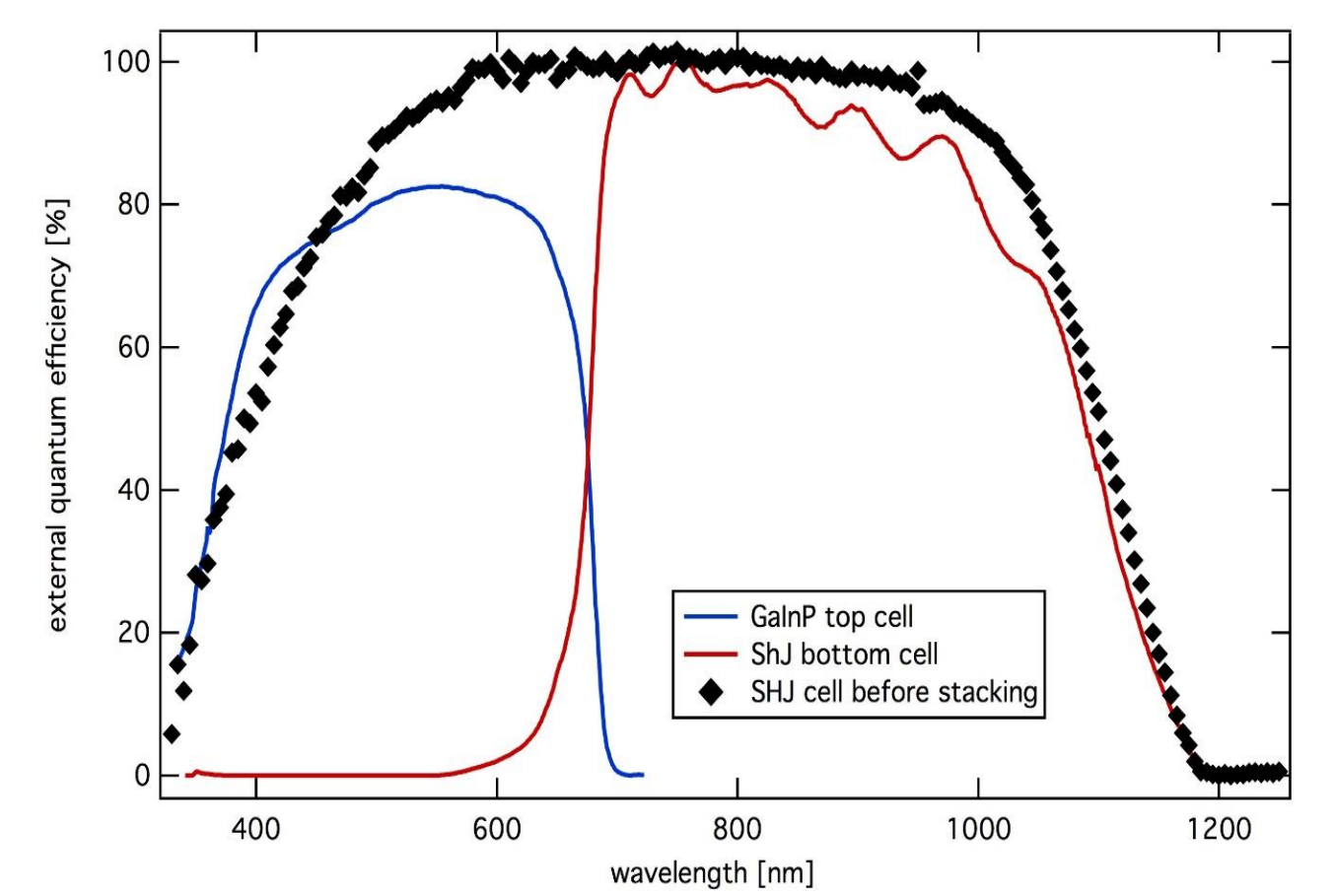


The resulting tandem cells are 4-terminal mechanically-stacked GalnP/Si tandem cells.

### RECORD EFFICIENCY:

#### Optical Analysis:

GalnP top cell with higher EQE than SHJ bottom cell for wavelengths < 450 nm, however with EQE limited to 83% (limited diffusion length in GalnP absorber and parasitic absorption in AlInP window layer). Optical coupling optimization in the tandem and low top cell sub-bandgap absorption enable for high EQE in the bottom cell. Oscillations in EQE due to interferences caused by the top cell.



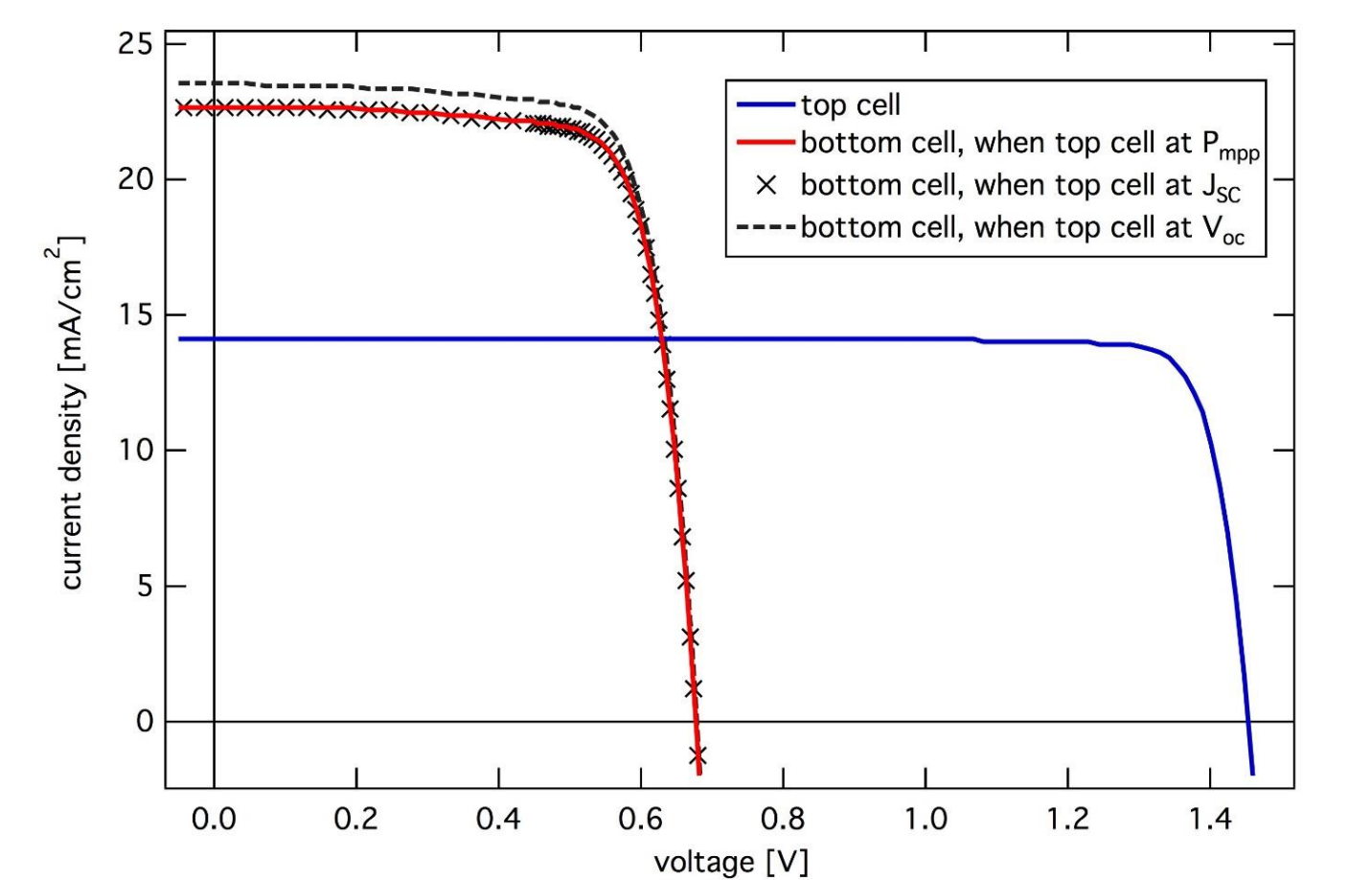
Normalized External Quantum Efficiency of the GalnP/Si tandem device

#### J-V characteristics:

Certified J-V curves measured at NREL, under AM1.5g spectral condition at 1 sun.

**Top cell:** J<sub>SC</sub> of 14.2 mA/cm<sup>2</sup>, V<sub>OC</sub> of 1.456 V for efficiency of (18.1 ± 0.5)%.

**Bottom cell:** Luminescent coupling tested with bottom cell measured for top cell operating at J<sub>SC</sub>, P<sub>mpp</sub> and V<sub>OC</sub>. J<sub>SC</sub> in the Si bottom cell 0.8 mA/cm<sup>2</sup> larger when the top cell is at V<sub>OC</sub> than at J<sub>SC</sub>, due to radiative recombination in top cell. Accurate analysis of the cumulative tandem cell efficiency requires bottom cell JV-curve measured with top cell at its maximum power point.



NREL certified current-voltage characteristics of the GalnP top cell and Si bottom cell of our tandem device, with an illuminated area of A<sub>tandem</sub> = 1.006 cm<sup>2</sup>. The JV-curve of the bottom cell was measured while the top cell was at V<sub>OC</sub>, J<sub>SC</sub> or P<sub>mpp</sub>.

Bottom cell generates J<sub>SC</sub> of 22.7 mA/cm<sup>2</sup> and V<sub>OC</sub> of 677 mV reaching efficiency of (11.7 ± 0.4)% in the tandem device.

#### Tandem performance:

The 4-terminal mechanically-stacked GalnP/Si tandem cell shows certified cumulative tandem cell efficiency of (29.8 ± 0.6)%. This is the III-V/Si multi-junction solar cell with the highest one-sun efficiency, exceeding the theoretical efficiency limit 29.4% and the record experimental efficiency value 25.6% of a Si single-junction, 1-sun solar cell and exceeding record efficiency 1-sun GaAs device (28.8%).

cell	Jsc [mA/cm <sup>2</sup> ]	Voc [mV]	FF [%]	eff. [%]
GalnP top cell	14.15	1456	87.9	18.1 ± 0.5
bottom cell when top cell at V <sub>OC</sub>	23.53	678	75.9	12.1 ± 0.4
bottom cell when top cell at J <sub>SC</sub>	22.68	677	76.0	11.7 ± 0.4
bottom cell when top cell at P <sub>mpp</sub>	22.70	677	76.2	11.7 ± 0.4
<b>Certified results</b>				<b>cumulative eff. 29.8 ± 0.6</b>

#### Perspectives:

This first joint development highlighted limitations that can be overcome. For the bottom cell, low V<sub>OC</sub> due to process-induced degradation during fabrication: +10-40 mV can be expected, > 700 mV in the tandem configuration (i.e. at 23 mA/cm<sup>2</sup> instead of 39 mA/cm<sup>2</sup>). J<sub>SC</sub> in the Si bottom cell is 0.7 mA/cm<sup>2</sup> smaller than the maximum photon current calculated. Current in the top cell can be optimized (maximum EQE shifted up). Overall, efficiencies > 30% are potentially achievable with our tandem cell design in short-term.

**29.8 % Certified Efficiency**